



DCR2930Y42

Phase Control Thyristor

DS3836-2 March 2013 (LN30239)

FEATURES

- Double Side Cooling
- High Surge Capability

APPLICATIONS

- High Power Drives
- High Voltage Power Supplies
- Static Switches

VOLTAGE RATINGS

Part and Ordering Number	Repetitive Peak Voltages V _{DRM} and V _{RRM} V	Conditions
DCR2930Y42 DCR2930Y40 DCR2930Y35 DCR2930Y30	4200 4000 3500 3000	$\begin{split} T_{vj} &= \text{-}40^{\circ}\text{C to } 125^{\circ}\text{C}, \\ I_{DRM} &= I_{RRM} = 200\text{mA}, \\ V_{DRM}, V_{RRM} t_p &= 10\text{ms}, \\ V_{DSM} \& V_{RSM} &= \\ V_{DRM} \& V_{RRM} + 100V \\ respectively \end{split}$

Lower voltage grades available.

ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

DCR2930Y42

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

KEY PARAMETERS

 $\begin{array}{lll} V_{DRM} & 4200V \\ I_{T(AV)} & 2930A \\ I_{TSM} & 40600A \\ dV/dt^* & 1500V/\mu s \\ dI/dt & 400A/us \end{array}$

* Higher dV/dt selections available

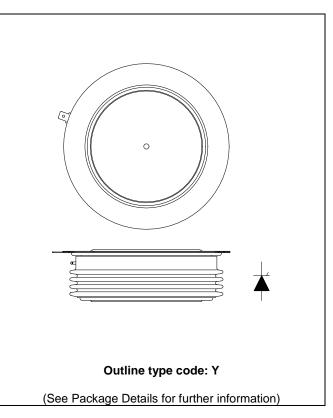


Fig. 1 Package outline





CURRENT RATINGS

$T_{case} = 60$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Double Si				
I _{T(AV)}	Mean on-state current	Half wave resistive load	2930	Α
I _{T(RMS)}	RMS value	-	4600	Α
I _T	Continuous (direct) on-state current	-	4210	Α

SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
I _{TSM}	Surge (non-repetitive) on-state current	10ms half sine, T _{case} = 125°C	40.6	kA
l ² t	I ² t for fusing	$V_R = 0$	8.24	MA ² s

THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions		Min.	Max.	Units
R _{th(j-c)}	Thermal resistance – junction to case	Double side cooled	DC	-	0.00835	°C/W
		Single side cooled	Anode DC	-	0.0134	°C/W
			Cathode DC	-	0.023	°C/W
R _{th(c-h)}	Thermal resistance – case to heatsink	Clamping force 54.0kN	Double side	-	0.002	°C/W
		(with mounting compound)	Single side	1	0.004	°C/W
T_{vj}	Virtual junction temperature	Blocking V _{DRM} / _{VRRM}		ı	125	°C
T _{stg}	Storage temperature range			-55	125	°C
F _m	Clamping force			48	59	kN





DYNAMIC CHARACTERISTICS

Symbol	Parameter	Test Conditio	Test Conditions		Max.	Units
I _{RRM} /I _{DRM}	Peak reverse and off-state current	At V _{RRM} /V _{DRM} , T _{case} = 125°C		-	200	mA
dV/dt	Max. linear rate of rise of off-state voltage	To 67% V_{DRM} , $T_j = 125$ °C, ga	ate open	-	1500	V/µs
dl/dt	Rate of rise of on-state current	From 67% V _{DRM} to 2x I _{T(AV)}	Repetitive 50Hz	-	150	A/µs
		Gate source 30V, 10Ω,	Non-repetitive	-	400	A/µs
		$t_r < 0.5 \mu s, T_j = 125^{\circ}C$				
V _{T(TO)}	Threshold voltage – Low level	500A to 3000A at T _{case} = 125	5°C	-	0.82	V
	Threshold voltage – High level	3000A to 7200A at T _{case} = 125°C		-	0.98	V
r _T	On-state slope resistance – Low level	500A to 3000A at T _{case} = 125°C		-	0.292	mΩ
	On-state slope resistance – High level	3000A to 7200A at T _{case} = 125°C		-	0.198	mΩ
t _{gd}	Delay time	$V_D = 67\% V_{DRM}$, gate source 30V, 10Ω		TBD	TBD	μs
		$t_r = 0.5 \mu s, T_j = 25^{\circ}C$				
tq	Turn-off time	$T_j = 125$ °C, $V_R = 200$ V, $dI/dt = 1$ A/ μ s,		250	500	μs
		dV _{DR} /dt = 20V/μs linear				
Qs	Stored charge	$I_T = 2000A$, $T_j = 125$ °C, $dI/dt - 1A/\mu s$,		1200	3500	μC
ΙL	Latching current	$T_j = 25^{\circ}C, V_D = 5V$		-	3	А
I _H	Holding current	$T_j = 25$ °C, $R_{G-K} = \infty$, $I_{TM} = 500$ A, $I_T = 5$ A		-	300	mA



GATE TRIGGER CHARACTERISTICS AND RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
V_{GT}	Gate trigger voltage	$V_{DRM} = 5V$, $T_{case} = 25$ °C	1.5	V
V_{GD}	Gate non-trigger voltage	At V _{DRM} , T _{case} = 125°C	TBD	V
I _{GT}	Gate trigger current	$V_{DRM} = 5V$, $T_{case} = 25$ °C	350	mA
I _{GD}	Gate non-trigger current	V _{DRM} = 5V, T _{case} = 25°C	TBD	mA

CURVES

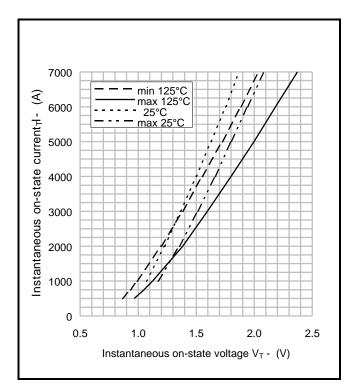


Fig.2 Maximum & minimum on-state characteristics

V_{TM} EQUATION

 $V_{TM} = A + Bln (I_T) + C.I_T + D.\sqrt{I_T}$

Where A = 0.866995

B = -0.042053

C = 0.000100

D = 0.014062

these values are valid for T_j = 125°C for I_T 500A to 10,000A

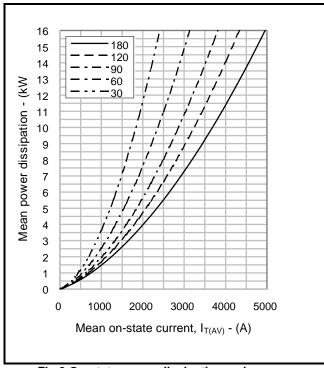


Fig.3 On-state power dissipation – sine wave

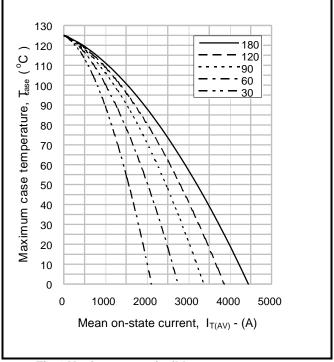


Fig.4 Maximum permissible case temperature, double side cooled – sine wave

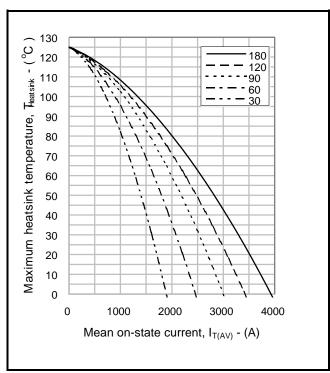


Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave

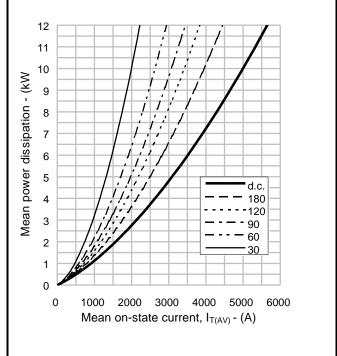
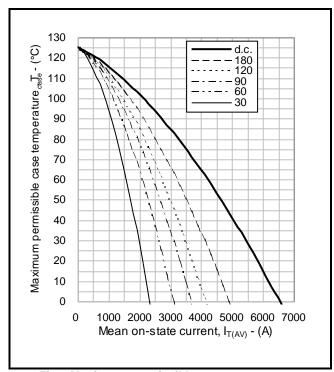
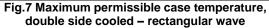


Fig.6 On-state power dissipation - rectangular wave





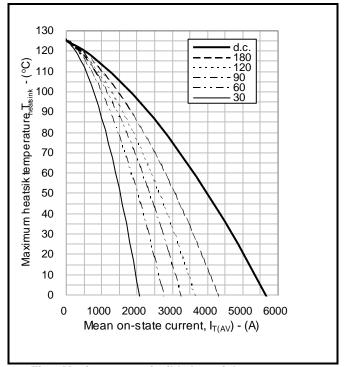
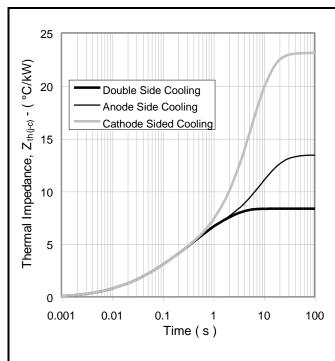


Fig.8 Maximum permissible heatsink temperature, double side cooled – rectangular wave



		1	2	3	4
Double side cooled	R _i (°C/kW)	0.612	1.7721	3.1053	2.8608
	T _i (s)	0.010332	0.056415	0.333082	1.6323
Anode side cooled	R _i (°C/kW)	0.7009	1.9388	3.61	7.1383
	T _i (s)	0.011328	0.065993	0.419695	9.0612
Cathode side coole	R _i (°C/kW)	0.6728	2.0168	1.7306	18.6391
	T _i (s)	0.010954	0.065544	0.30379	5.7274

 $Z_{th} = \sum [R_i x (1-exp. (t/t_i))]$ [1]

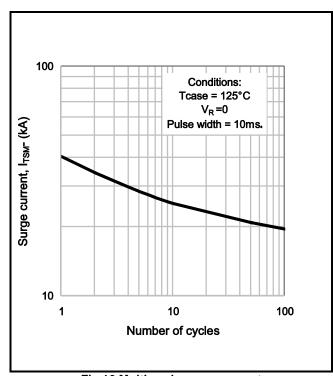
 $\Delta R_{\text{th(j-c)}}$ Conduction

Tables show the increments of thermal resistance $R_{\text{th}(j\text{-}c)}$ when the device operates at conduction angles other than d.c.

Double side cooling				Anode Side Cooling		
	$\Delta Z_{th}(z)$				ΔZ_t	_h (z)
θ°	sine.	rect.		θ°	sine.	rect.
180	0.94	0.65		180	0.94	0.64
120	1.09	0.92		120	1.08	0.91
90	1.24	1.07		90	1.23	1.06
60	1.38	1.23		60	1.37	1.22
30	1.49	1.40		30	1.47	1.38
15	1.54	1.49		15	1.52	1.47

Cath	Cathode Sided Cooling				
	ΔZ_{th} (z)				
θ°	sine.	rect.			
180	0.94	0.64			
120	1.08	0.91			
90	1.24	1.06			
60	1.37	1.22			
30	1.48	1.39			
15	1 52	1 10			

Fig.9 Maximum (limit) transient thermal impedance - junction to case (°C/kW)





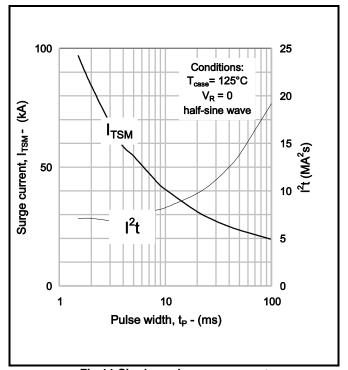


Fig.11 Single-cycle surge current

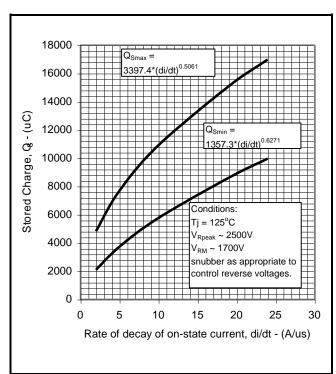


Fig.12 Stored Charge

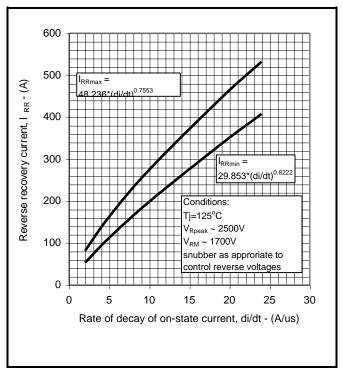


Fig.13 Reverse Recovery Current

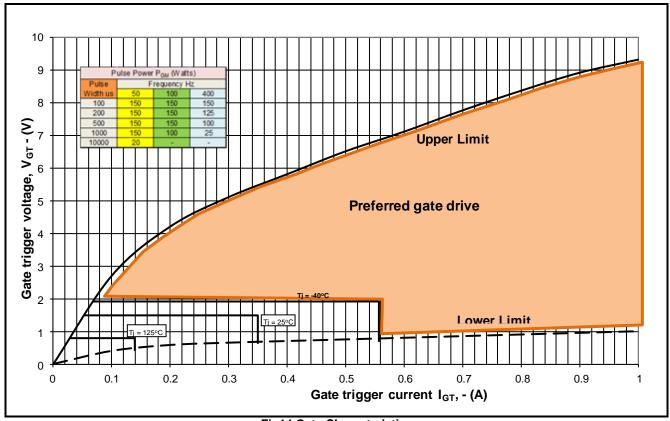


Fig14 Gate Characteristics

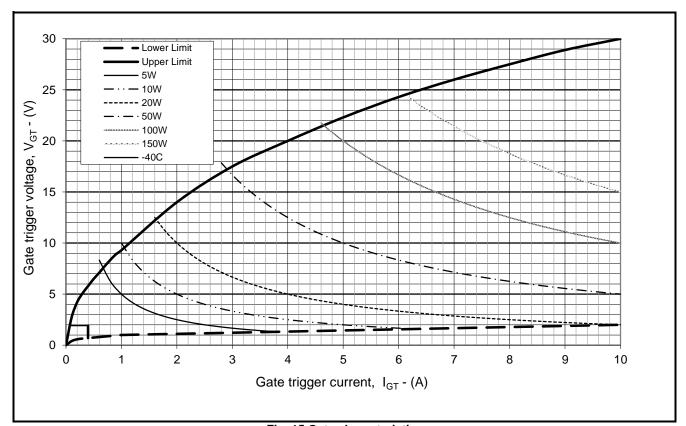


Fig. 15 Gate characteristics



PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

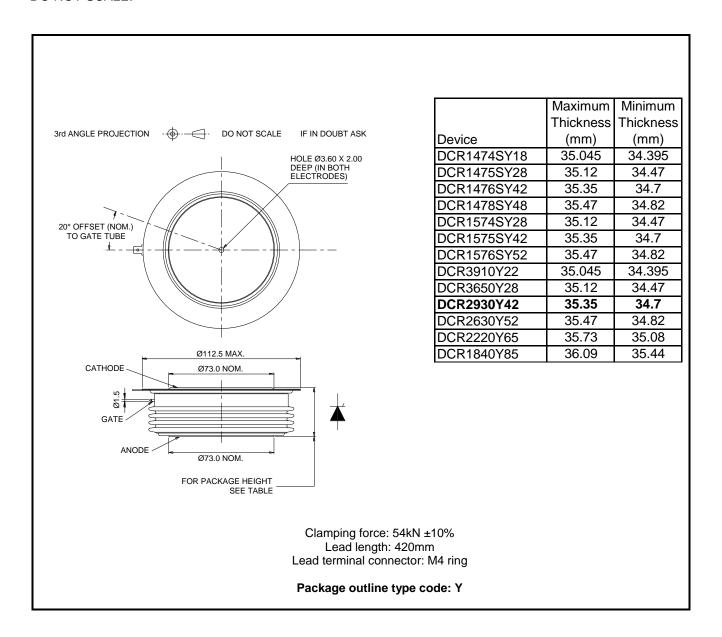


Fig.16 Package outline





IMPORTANT INFORMATION:

This publication is provided for information only and not for resale.

The products and information in this publication are intended for use by appropriately trained technical personnel.

Due to the diversity of product applications, the information contained herein is provided as a general guide only and does not constitute any guarantee of suitability for use in a specific application. The user must evaluate the suitability of the product and the completeness of the product data for the application. The user is responsible for product selection and ensuring all safety and any warning requirements are met. Should additional product information be needed please contact Customer Service.

Although we have endeavoured to carefully compile the information in this publication it may contain inaccuracies or typographical errors. The information is provided without any warranty or guarantee of any kind.

This publication is an uncontrolled document and is subject to change without notice. When referring to it please ensure that it is the most up to date version and has not been superseded.

The products are not intended for use in applications where a failure or malfunction may cause loss of life, injury or damage to property. The user must ensure that appropriate safety precautions are taken to prevent or mitigate the consequences of a product failure or malfunction.

The products must not be touched when operating because there is a danger of electrocution or severe burning. Always use protective safety equipment such as appropriate shields for the product and wear safety glasses. Even when disconnected any electric charge remaining in the product must be discharged and allowed to cool before safe handling using protective gloves.

Extended exposure to conditions outside the product ratings may affect reliability leading to premature product failure. Use outside the product ratings is likely to cause permanent damage to the product. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture, a large current to flow or high voltage arcing, resulting in fire or explosion. Appropriate application design and safety precautions should always be followed to protect persons and property.

Product Status & Product Ordering:

No Annotation:

We annotate datasheets in the top right hand corner of the front page, to indicate product status if it is not yet fully approved for production. The annotations are as follows:-

Target Information: This is the most tentative form of information and represents a very preliminary specification.

No actual design work on the product has been started.

Provisional Information: Some initial development work has been performed. The datasheet represents a view of the

end product based on very limited information. Certain details will change.

Preliminary Information:The product design is complete and final characterisation for volume production is in progress. The datasheet represents the product as it is now understood but details may change.

The product has been approved for production and unless otherwise notified by Dynex any product ordered will be supplied to the current version of the data sheet prevailing at the

time of our order acknowledgement.

All products and materials are sold and services provided subject to Dynex's conditions of sale, which are available on request.

Any brand names and product names used in this publication are trademarks, registered trademarks or trade names of their respective owners.

HEADQUARTERS OPERATIONS

DYNEX SEMICONDUCTOR LIMITED Doddington Road, Lincoln, Lincolnshire, LN6 3LF United Kingdom.

Phone: +44 (0) 1522 500500 Fax: +44 (0) 1522 500550 Web: http://www.dynexsemi.com

CUSTOMER SERVICE

Phone: +44 (0) 1522 502753 / 502901

Fax: +44 (0) 1522 500020

e-mail: power_solutions@dynexsemi.com

© Dynex Semiconductor Ltd. Technical Documentation – Not for resale.